
CHT-NMOS40XX - DATASHEET

Version: 03.10
15-Feb-21
(Last Modification Date)

High-Temperature, 40V N-channel Power MOSFET

General description

The CHT-NMOS-40xx is a high voltage N-channel power MOSFET family designed to achieve high performance in an extremely wide temperature range: typical operation temperature goes from -55°C to 225°C.

CHT-NMOS40 parts sustain the highest temperatures while keeping leakage currents low.

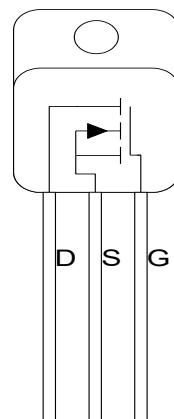
Markets

- Aeronautics & aerospace,
- Oil & Gas,
- Industrial,
- Automotive.

Features

- Specified from -55 to +225°C (Tj)
- Drain voltage up to 40V
- Typical output current:
 - CHT-NMOS-4005: 5A @ 25°C
 - CHT-NMOS-4010: 10A @ 25°C
 - CHT-NMOS-4020: 20A @ 25°C
- $R_{DS(on)}$:
 - CHT-NMOS-4005: 0.65Ω @ 225°C
 - CHT-NMOS-4010: 0.36Ω @ 225°C
 - CHT-NMOS-4020: 0.25Ω @ 225°C
- VGS = 0V to +5V
- Reverse ESD diode between gate and source.
- Validated at 225°C for 1000 hours (and still on-going)
- Available in TO254 package

Package configurations¹



TO254 (Top view) (Case floating)

¹ Other packages available upon request.

Absolute Maximum Ratings

Gate-to-Source voltage V_{GS}	-0.5V to 5.5V
Pulsed drain current I_{DS} ($T_{pulse} \leq 2\mu s$):	
• CHT-NMOS4005:	7A @ -55°C 6A @ 25°C 4A @ 225°C
• CHT-NMOS4010:	14A @ -55°C 12A @ 25°C 8A @ 225°C
• CHT-NMOS4020:	28A @ -55°C 22A @ 25°C 16A @ 225°C
Power dissipation $T_c=25^\circ C$	
• CHT-NMOS4005:	40W
• CHT-NMOS4010:	66W
• CHT-NMOS4020:	100W
DC drain current ($V_{GS}=5V$)	
• CHT-NMOS4005:	5A
• CHT-NMOS4010:	10A
• CHT-NMOS4020:	20A
Junction temperature T_j	300°C

ESD Rating

Human Body Model	2kV
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Operating Conditions

Gate-to-Source voltage V_{GS}	0V to 5V
Drain-to-Source voltage V_{DS}	0V to 40V
DC drain current ($V_{GS}=5V$)($TC=175^\circ C$)	
• CHT-NMOS4005:	4A
• CHT-NMOS4010:	6.8A
• CHT-NMOS4020:	10A
Junction temperature	-55°C to +225°C
See Thermal characteristics for power derating with temperature	

Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Frequent or extended exposure to absolute maximum rating conditions or above may affect device reliability.

Electrical characteristics of CHT-NMOS4005

DC Characteristics

Unless otherwise stated, $T_j = 25^\circ\text{C}$. **Bold** figures point out values valid over the whole temperature range ($T_j = -55^\circ\text{C}$ to $+225^\circ\text{C}$).

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Threshold voltage	V_{TH}	$V_{DS} = 50\text{mV}$	0.85	1.6	1.95	V
Drain cut-off current	I_{DSS}	$V_{GS} = 0\text{V}, V_{DS} = 40\text{V}, T_j = 25^\circ\text{C}$		15		nA
		$V_{GS} = 0\text{V}, V_{DS} = 40\text{V}, T_j = 225^\circ\text{C}$		8		uA
Gate leakage current ¹	I_{GSS}	$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 25^\circ\text{C}$		189		pA
		$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 225^\circ\text{C}$		72.1		nA
Static drain-to-source resistance	R_{Dson}	$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = -55^\circ\text{C}$		0.3		Ω
		$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 25^\circ\text{C}$		0.38		Ω
		$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 225^\circ\text{C}$		0.65		Ω
Breakdown drain-to-source voltage ²	V_{BRDS}	$V_{GS} = 0\text{V}$	40			V

Dynamic Characteristics

Unless otherwise stated, $T_j = 25^\circ\text{C}$. **Bold** figures point out values valid over the whole temperature range ($T_j = -55^\circ\text{C}$ to $+225^\circ\text{C}$).

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Input capacitance	C_{ISS}	$V_{GS} = 0V_{DC}, DS$ shorted		370		pF
Output capacitance	C_{OSS}	$V_{GS} = 0V_{DC}, V_{DS} = 40V_{DC}$		50		pF
Feedback capacitance	C_{RSS}	$V_{GS} = 0V_{DC}, V_{DS} = 40V_{DC}$		21		pF
Gate to Source Charge	Q_{GS}	$V_{GS} = [0 \rightarrow 5]V; VD = 40V$		3.8		nC

Switching Characteristics

Unless otherwise stated, $T_j = 25^\circ\text{C}$. **Bold** figures point out values valid over the whole temperature range ($T_j = -55^\circ\text{C}$ to $+225^\circ\text{C}$).

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Turn-on delay time	$T_{d(ON)}$	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		30		ns
Rise time	T_r	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		50		ns
Turn-off delay time	$T_{d(OFF)}$	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		35		ns
Fall time	T_f	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		15		ns
Drain current	I_D	$V_{DS} = 40V, V_{GS} = 5V$ 2 μs pulse, -55°C		6.6		A
		$V_{DS} = 40V, V_{GS} = 5V$ 2 μs pulse, 25°C		5.7		A
		$V_{DS} = 40V, V_{GS} = 5V$ 2 μs pulse, 225°C		3.9		A

¹ Includes ESD diode leakage current.

² Voltage for which the cut-off current evolution versus V_{DS} becomes exponential.

Electrical characteristics of CHT-NMOS4010

DC Characteristics

Unless otherwise stated, $T_j = 25^\circ\text{C}$. **Bold** figures point out values valid over the whole temperature range ($T_j = -55^\circ\text{C}$ to $+225^\circ\text{C}$).

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Threshold voltage	V_{TH}	$V_{DS} = 50\text{mV}$	0.85	1.55	1.95	V
Drain cut-off current	I_{DSS}	$V_{GS} = 0\text{V}, V_{DS} = 40\text{V}, T_j = 25^\circ\text{C}$		25		nA
		$V_{GS} = 0\text{V}, V_{DS} = 40\text{V}, T_j = 225^\circ\text{C}$		10		uA
Gate leakage current ³	I_{GSS}	$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 25^\circ\text{C}$		204		pA
		$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 225^\circ\text{C}$		294		nA
Static drain-to-source resistance	R_{Dson}	$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = -55^\circ\text{C}$		0.16		Ω
		$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 25^\circ\text{C}$		0.2		Ω
		$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 225^\circ\text{C}$		0.36		Ω
Breakdown drain-to-source voltage ⁴	V_{BRDS}	$V_{GS} = 0\text{V}$	40			V

Dynamic Characteristics

Unless otherwise stated, $T_j = 25^\circ\text{C}$. **Bold** figures point out values valid over the whole temperature range ($T_j = -55^\circ\text{C}$ to $+225^\circ\text{C}$).

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Input capacitance	C_{ISS}	$V_{GS} = 0V_{DC}, DS$ shorted		720		pF
Output capacitance	C_{OSS}	$V_{GS} = 0V_{DC}, V_{DS} = 80V_{DC}$		93		pF
Feedback capacitance	C_{RSS}	$V_{GS} = 0V_{DC}, V_{DS} = 80V_{DC}$		42		pF
Gate to Source Charge	Q_{GS}	$V_{GS} = [0 \rightarrow 5]V; VD = 40V$		7.6		nC

Switching Characteristics

Unless otherwise stated, $T_j = 25^\circ\text{C}$. **Bold** figures point out values valid over the whole temperature range ($T_j = -55^\circ\text{C}$ to $+225^\circ\text{C}$).

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Turn-on delay time	$T_{d(ON)}$	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		35		ns
Rise time	T_r	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		60		ns
Turn-off delay time	$T_{d(OFF)}$	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		53		ns
Fall time	T_f	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		24		ns
Drain current	I_D	$V_{DS} = 40V, V_{GS} = 5V$ 2 μs pulse, -55°C		12.8		A
		$V_{DS} = 40V, V_{GS} = 5V$ 2 μs pulse, 25°C		11.2		A
		$V_{DS} = 40V, V_{GS} = 5V$ 2 μs pulse, 225°C		7.6		A

³ Includes ESD diode leakage current.

⁴ Voltage for which the cut-off current evolution versus V_{DS} becomes exponential.

Electrical characteristics of CHT-NMOS4020

DC Characteristics

Unless otherwise stated, $T_j = 25^\circ\text{C}$. **Bold** figures point out values valid over the whole temperature range ($T_j = -55^\circ\text{C}$ to $+225^\circ\text{C}$).

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Threshold voltage	V_{TH}	$V_{DS} = 50\text{mV}$	0.85	1.6	1.95	V
Drain cut-off current	I_{DSS}	$V_{GS} = 0\text{V}, V_{DS} = 40\text{V}, T_j = 25^\circ\text{C}$		40		nA
		$V_{GS} = 0\text{V}, V_{DS} = 40\text{V}, T_j = 225^\circ\text{C}$		20		uA
Gate leakage current ⁵	I_{GSS}	$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 25^\circ\text{C}$		TBD		nA
		$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 225^\circ\text{C}$		TBD		uA
Static drain-to-source resistance	R_{Dson}	$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = -55^\circ\text{C}$		0.1		Ω
		$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 25^\circ\text{C}$		0.12		Ω
		$V_{GS} = 5\text{V}, V_{DS} = 50\text{mV}, T_j = 225^\circ\text{C}$		0.25		Ω
Breakdown drain-to-source voltage ⁶	V_{BRDS}	$V_{GS} = 0\text{V}$	40			V

Dynamic Characteristics

Unless otherwise stated, $T_j = 25^\circ\text{C}$. **Bold** figures point out values valid over the whole temperature range ($T_j = -55^\circ\text{C}$ to $+225^\circ\text{C}$).

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Input capacitance	C_{ISS}	$V_{GS} = 0V_{DC}, DS$ shorted		1.84		nF
Output capacitance	C_{OSS}	$V_{GS} = 0V_{DC}, V_{DS} = 80V_{DC}$		TBD		pF
Feedback capacitance	C_{RSS}	$V_{GS} = 0V_{DC}, V_{DS} = 80V_{DC}$		TBD		pF
Gate to Source Charge	Q_{GS}	$V_{GS} = [0 \rightarrow 5]V; VD = 40V$		15.2		nC

Switching Characteristics

Unless otherwise stated, $T_j = 25^\circ\text{C}$. **Bold** figures point out values valid over the whole temperature range ($T_j = -55^\circ\text{C}$ to $+225^\circ\text{C}$).

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Turn-on delay time	$T_{d(ON)}$	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		TBD		ns
Rise time	T_r	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		TBD		ns
Turn-off delay time	$T_{d(OFF)}$	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		TBD		ns
Fall time	T_f	$V_{DS} = 20V, V_{GS} = 5V$ 2 μs pulse, $R_G = 2.7\Omega, R_D = 8.2\Omega$		TBD		ns
Drain current	I_D	$V_{DS} = 40V, V_{GS} = 5V$ 2 μs pulse, -55°C		28		A
		$V_{DS} = 40V, V_{GS} = 5V$ 2 μs pulse, 25°C		22		A
		$V_{DS} = 40V, V_{GS} = 5V$ 2 μs pulse, 225°C		16		A

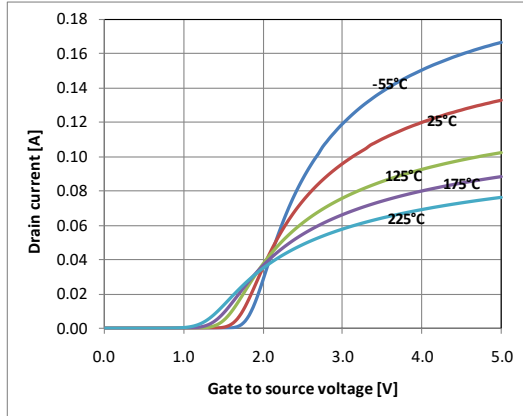
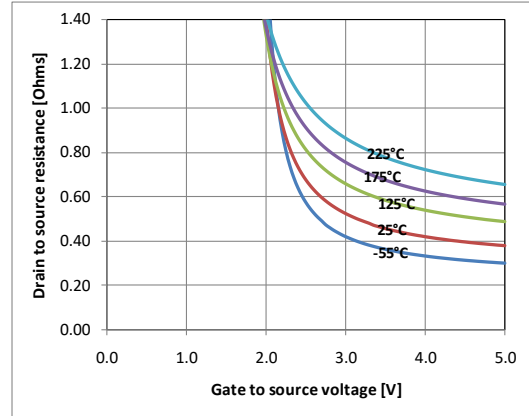
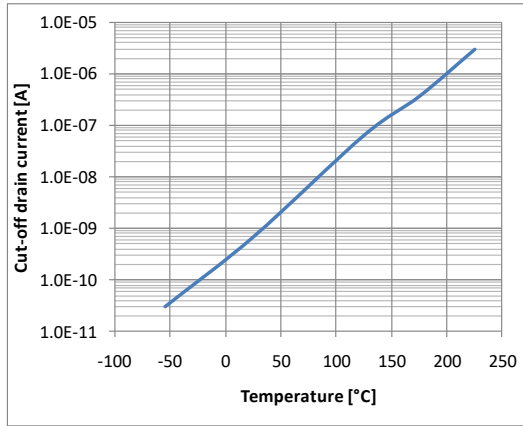
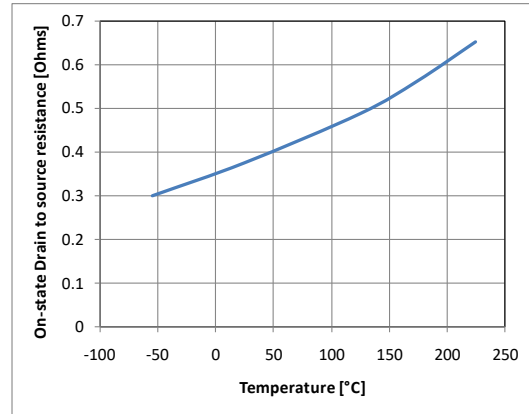
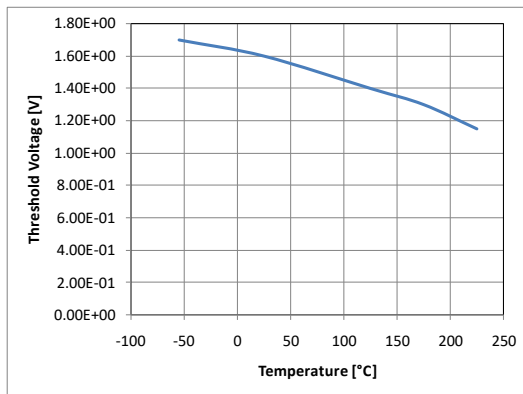
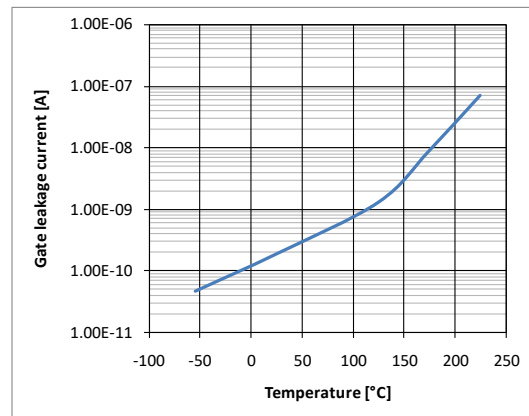
Thermal Characteristics

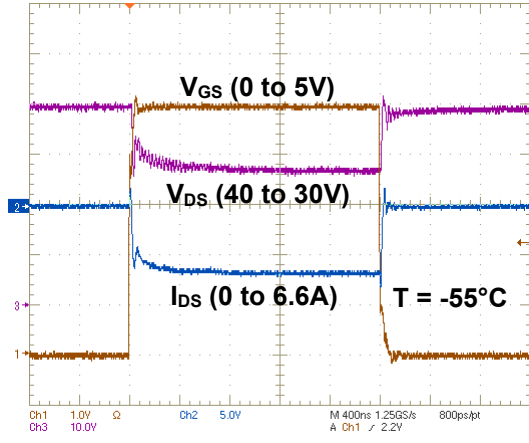
Parameter	Symbol	Condition	Min	Typ	Max	Unit
Thermal resistance (junction to case, TO-254 package) CHT-NMOS4005 CHT-NMOS4010 CHT-NMOS4020	Θ_{JC}			5 3 2		$^\circ\text{C/W}$

⁵ Includes ESD diode leakage current.

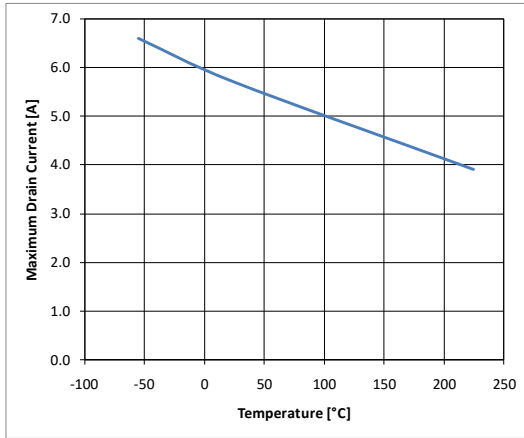
⁶ Voltage for which the cut-off current evolution versus V_{DS} becomes exponential.

Typical Performance Characteristics of CHT-NMOS4005

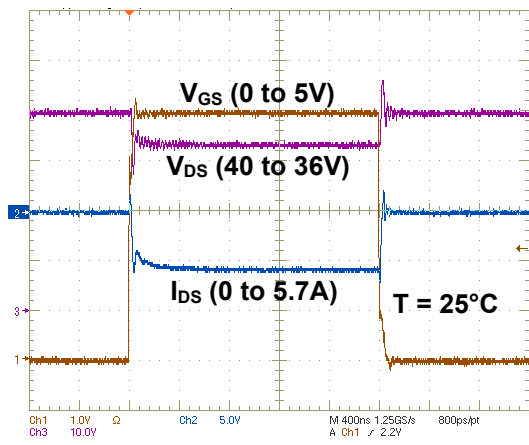

Drain current vs. gate voltage ($V_D = 50\text{mV}$)

Drain source resistance vs. Drain source voltage ($V_D = 50\text{mV}$)

Cut-off current vs. temperature ($V_G = 0\text{V}$, $V_D = 40\text{V}$)

On-state drain source resistance vs. temperature ($V_G = 5\text{V}$, $V_D = 50\text{mV}$)

Threshold voltage vs. temperature

Gate and ESD diode leakage current vs. temperature ($V_G = 5\text{V}$, $V_D = 50\text{mV}$)



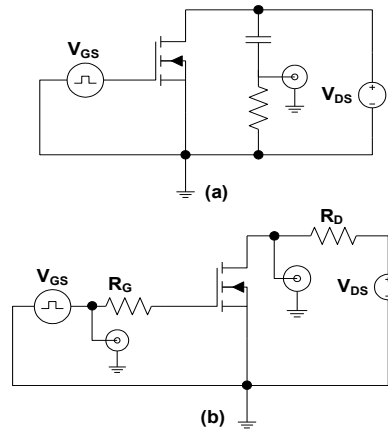
Maximum drain current pulse test (T = -55°C)



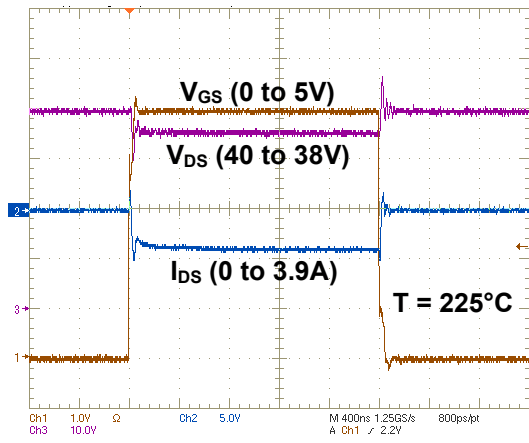
Peak drain current vs. temperature (V_G = 5V, V_D = 40V)



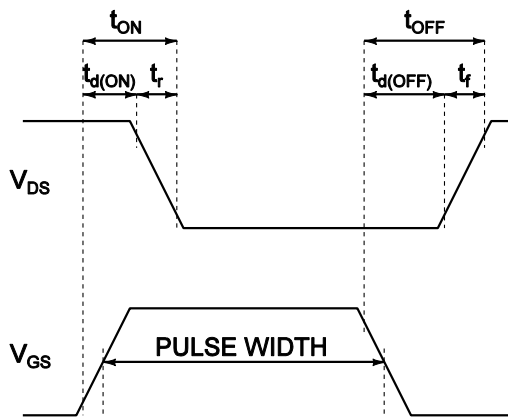
Maximum drain current pulse test (T = 25°C)



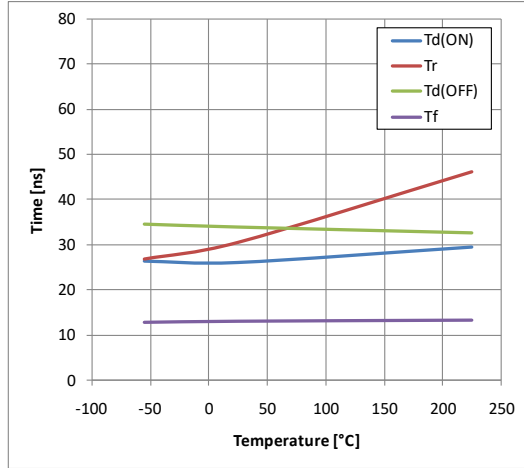
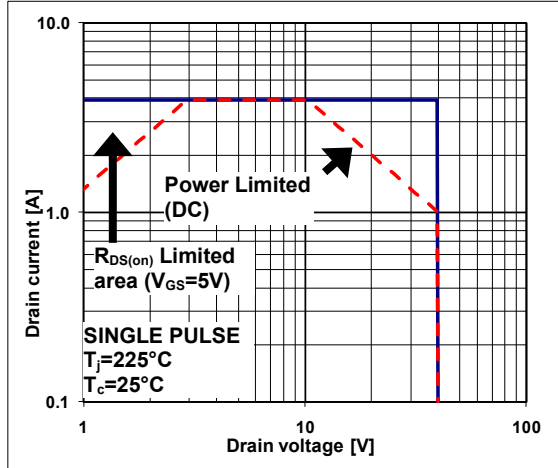
(a) I_D^{MAX} measurement scheme R=1Ω, C=100μF, Compliance (V_{DS}=40V)=20mA (b) Timing measurement scheme R_G=2.7Ω, R_D=8.2Ω, V_{DS}=20V



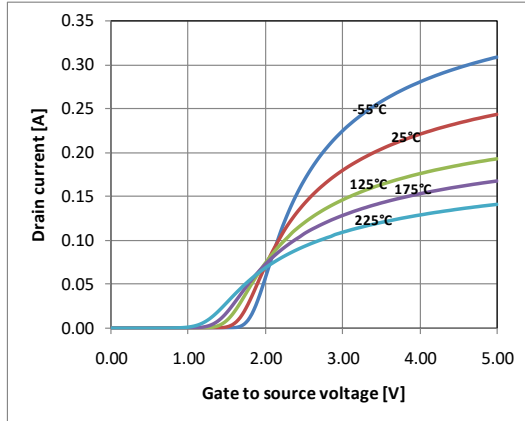
Maximum drain current pulse test (T = 225°C)



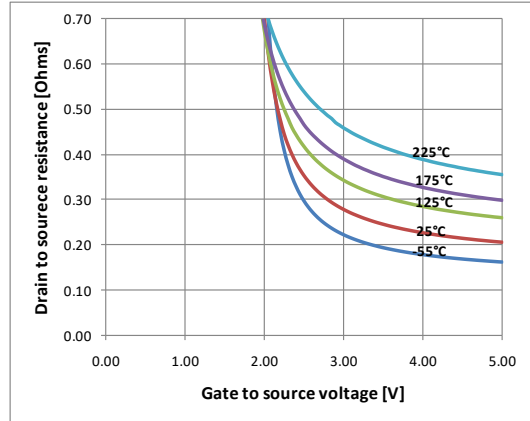
Timing definition diagram


Timing parameters versus temperature

Forward bias safe operating area.

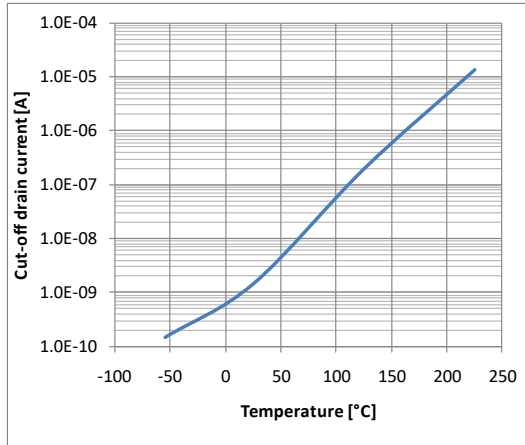
Typical Performance Characteristics of CHT-NMOS4010



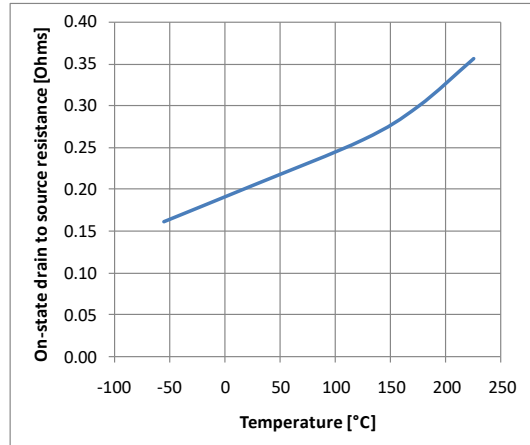
Drain current vs. Gate-source voltage ($V_D=50mV$).



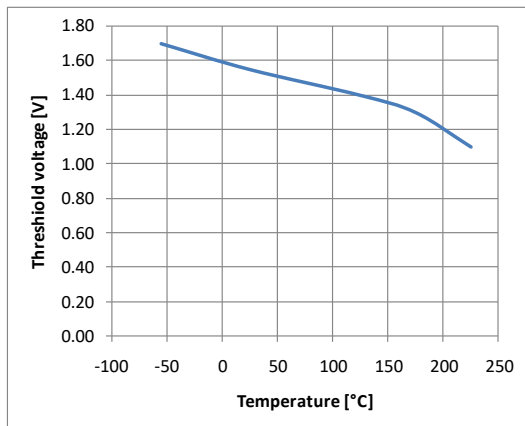
Drain source resistance vs. Gate-source voltage ($V_D=50mV$).



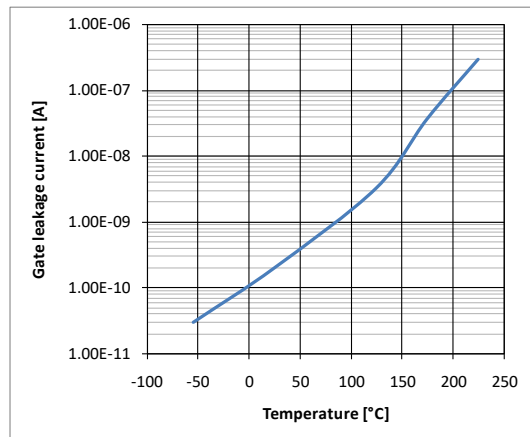
Cut-off current vs. temperature ($V_G=0V$, $V_D=40V$).



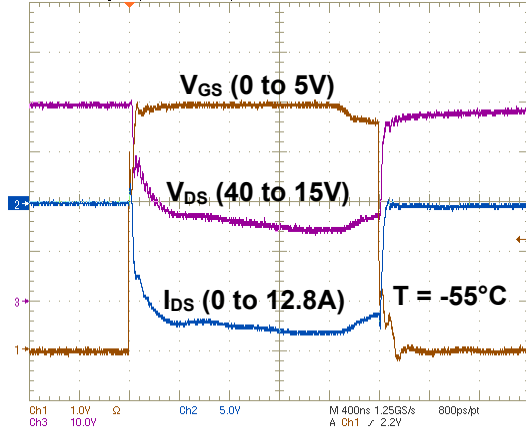
On-state drain source resistance vs. temperature ($V_G=5V$, $V_D=50mV$).



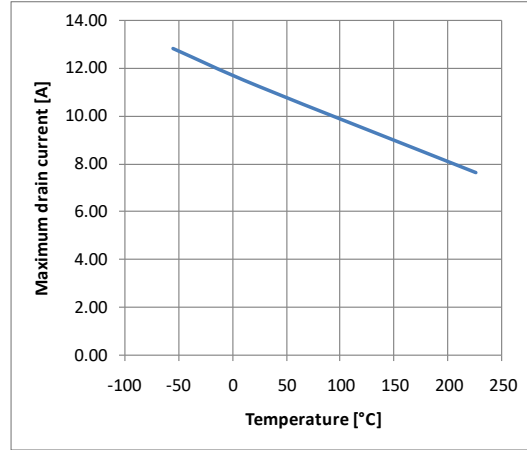
Threshold voltage vs. temperature.



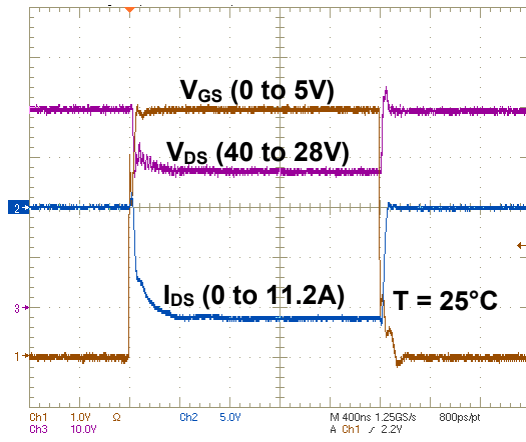
Gate and ESD diode leakage current vs. temperature ($V_G=5V$, $V_D=50mV$).



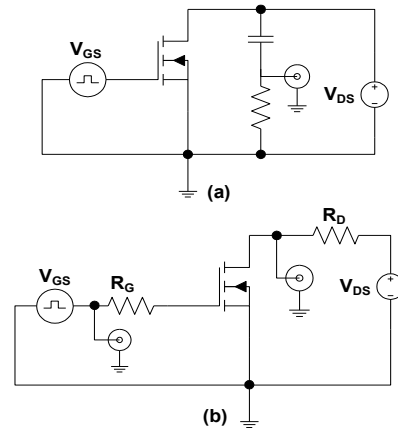
Maximum drain current pulse test (T=-55°C).



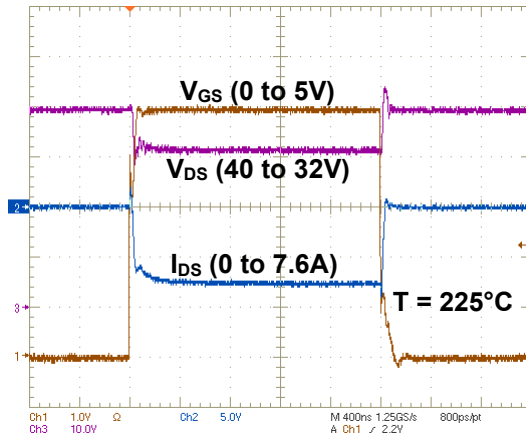
Peak drain current vs. temperature (V_G=5V, V_D=40V).



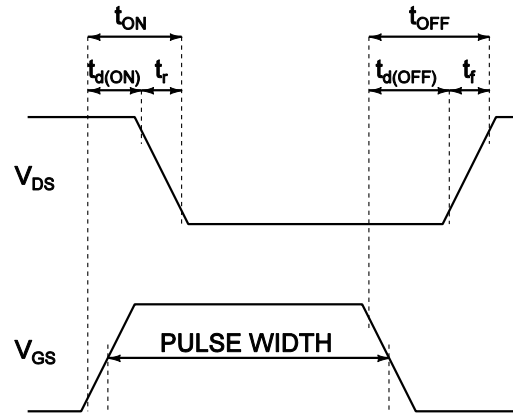
Maximum drain current pulse test (T=25°C).



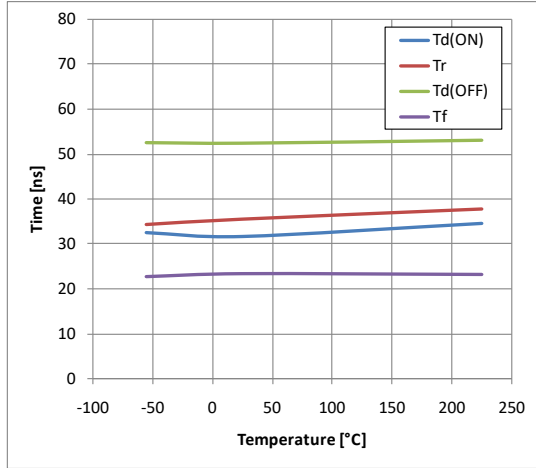
(a) I_D^{MAX} measurement scheme R=1Ω, C=100μF, Compliance (V_{DS}=40V)=20mA (b) Timing measurement scheme R_G=2.7Ω, R_D=8.2Ω, V_{DS}=20V.



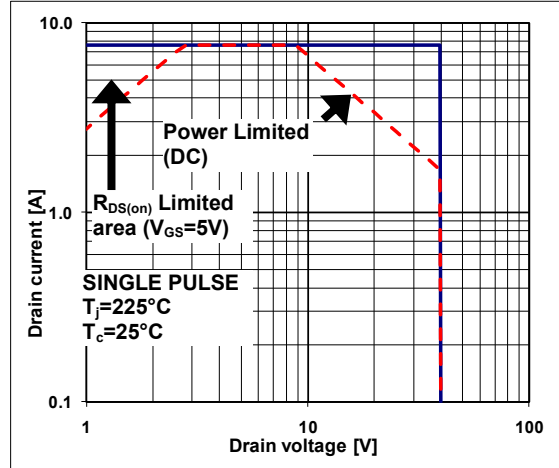
Maximum drain current pulse test (T=225°C).



Timing definition diagram.

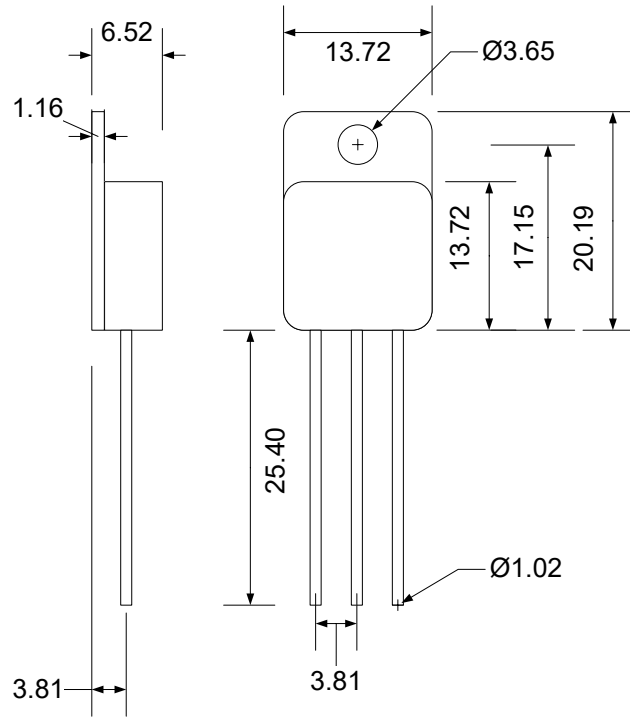


Timing parameters versus temperature.



Forward bias safe operating area.

Package Dimensions



TO254 (mm +/- 10%)

Ordering Information

Ordering Reference	Package	Temperature Range	Marking	Status
CHT-NMOS4005-TO254-T	TO-254 metal can	-55°C to +225°C	CHT-NMOS4005	Active
CHT-NMOS4010-TO254-T	TO-254 metal can	-55°C to +225°C	CHT-NMOS4010	Not for new design
CHT-NMOS4020-TO254-T	TO-254 metal can	-55°C to +225°C	CHT-NMOS4020	Not for new design

Contact & Ordering

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